## THE UNITED STATES PATENT AND TRADEMARK OFFICE

Appl. No. : 09/763,914 Applicant : STAHLER et al.

Filed : May 11, 2001

TC/A.U. : 1639

Examiner : Bennett M. Celsa

Docket No. : 2923-438 Customer No. : 06449 Confirmation No. : 3624

## INFORMATION DISCLOSURE STATEMENT

Director of the United States Patent and Trademark Office P.O. Box 1450 Alexandria, Virginia 22313-1450

## Dear Sir:

Under the provisions of 37 C.F.R. §§ 1.56, 1.97 and 1.98, Applicant submits herewith information that the Office may wish to consider in examination of the subject application. Materials submitted for consideration are listed on the attached form PTO-1449.

Applicants believe that no fee is due for this submission, however, if the Office deems a fee necessary, the Office is authorized to charge our deposit account number 02-2135.

RESPECTFULLY SUBMITTED,								
NAME AND REG. NUMBER	Indicha cabbiay							
SIGNATURE	DATE October 27, 200						er 27, 2005	
Address Rothwell, Figg, Ernst & Manbeck 1425 K Street, N.W., Swite 800								
City	Washington	State	D.C.		Zip Code		20005	
Country	U.S.A.	Telephone	202-783-6040		Fax		202-783-6031	

				Complete if Known		
				Application Number	09/763,914	
INFORMA"				Filing Date	May 11, 2001	
OCT 2 7 1005				First Named Inventor	STAHLER et al.	
				Group Art Unit	1639	
OCI P				Examiner Name	Bennett M. Celsa	
THE TRUE THE PARTY OF THE PARTY				Confirmation No.	3624	
Sheet 1 of 2			2	Attorney Docket Number	2923-438	

	U.S. PATENT DOCUMENTS							
Examiner Initials*		U.S. Patent Doo	cument	Name of Patentee or Applicant	Date of Publication of Cited Document MM-DD-YYYY			
	Cite No.1	Number	Kind Code <sup>2</sup> (if known)	of Cited Document				
	Α	5,318,679		Nishioka	06-07-1994			
	В	5,424,186		Fodor et al.	06-13-1995			
	С	5,545,531		Rava et al.	08-13-1996			
	D	6,001,311	A1	Brennan	12-14-1999			
	E	6,024,925	A1	Little et al.	02-15-2000			
	F	6,271,957	B1	Quate et al.	08-07-2001			
	G	6,375,903	B1	Cerrina et al.	04-23-2002			
	-							
		· ·						

<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

¹Unique citation designation number. ²See attached Kinds of U.S. Patent Documents. ³Enter Office that issued the document, by the two-letter code. ⁴For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. ⁴Applicant is to place a check mark here if English language translation is attached. AB indicates that only an English language abstract is attached.

			···	Complete if Known			
				Application Number	09/763,914		
INFORMATION				Filing Date	May 11, 2001		
STATEMENT E	BY APP	PLICA	NT	First Named Inventor	STAHLER et al.		
OPE WAR				Group Art Unit	1639		
OCT 2.7 2005				Examiner Name	Bennett M. Celsa		
				Confirmation No.	3624		
SHELITAGE	2	of	2	Attorney Docket Number	2923-438		

the solution

			FOR	EIGN PAT	ENT DOCUMENTS	
Examiner Initials*	Cite	Fo	oreign Patent Docun	nent	Name of Patentee or Applicant Publica	e of ation of
	No. <sup>1</sup>	Office <sup>3</sup> Code	Number <sup>4</sup>	Kind <sup>5</sup> (if known)		ocument D-YYYY T <sup>6</sup>
	Н	wo	98/08085		Science Applications International 02-26 Corporation	-1998
,	ı	wo	98/53093		Bioarray Solutions LLC, Rutgers The 11-26 State University of New Jersey	-1998
	J	wo	99/09042		Cepheid 02-25	-1999
	K	wo	99/42813		Wisconsin Alumni Research 08-26 Foundation	i-1999
	L	wo	99/60170		Hyseq, Inc. 11-25	-1999
	М	WO 99/60156			Epigenomics GmbH 11-25	-1999
	N	wo	99/63385		Boards of Regents, The University of Texas System	-1999
	0	WO 00/13017			Febit Ferrarius Biotechnology GmbH 03-09	-2000
	Р	WO 00/13018			Febit Ferrarius Biotechnology GmbH 03-09	-2000
	Q	DE	199 10 392		Institute Für Physikalische 09-07 Hochtechnologie e.V.	7-2000 AB
Examiner Signature					Date Considered	

<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

<sup>&</sup>lt;sup>1</sup>Unique citation designation number. <sup>2</sup>See attached Kinds of U.S. Patent Documents. <sup>3</sup>Enter Office that issued the document, by the two-letter code. <sup>4</sup>For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. <sup>5</sup>Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. <sup>6</sup>Applicant is to place a check mark here if English language translation is attached. AB indicates that only an English language abstract is attached.